

<b>Notice of References Cited</b>	Application/Control No. 10/668,874	Applicant(s)/Patent Under Reexamination OVADIA ET AL.	
	Examiner Kenneth J. Malkowski	Art Unit 2613	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,671,256	12-2003	Xiong et al.	370/230
*	B	US-2002/0154360	10-2002	Liu, Heyun H.	359/135
*	C	US-7,035,537	04-2006	Wang et al.	398/7
*	D	US-2002/0109878	08-2002	Qiao, Chunming	359/118
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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